

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination IWAMI ET AL.	
		Examiner	Art Unit	Page 1 of 1
EDMUND H. LEE		1732		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,816,937	10-1998	Shimosaka et al.	473/354
*	B	US-6,093,357	07-2000	Bissonette et al.	264/248
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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